

FBIS-II (Floating Battery Interconnection System Connector)

- 1. Introduction
- 1.1 Testing was performed on the Floating Battery Interconnection System (FBIS-II) Connector to determine if it meets the requirements of Product Specification, 108-61125 Rev.A
- 1.2 Scope

This report covers the electrical, mechanical and environmental performance requirements of the FBIS-II Connector.

The qualification testing was performed between 25 APR, 2011 and 27 MAY, 2011.

1.3 Conclusion

The FBIS-II Connector meets the electrical, mechanical and environmental performance requirements of Product Specification, 108-61125 Rev.A

Product Description

This product has been developed for Battery Pack of mobile phone etc.

Classification : Restricted to Motorola Inc.

#### 1.5 Test Samples

Samples were taken randomly from current production. The following samples were used:

Part Number	Description
1554829-3	FLOATING BATTERY INTERCONNECTION SYSTEMS RECEPTACLE ASSEMBLY
2134167-1	FBIS-II PLUG CONNECTOR 4POS H-TYPE

Fig. 1 (End)

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#### 2. Test Contents

Para.	Test Items	Requirements	Judgment
2.5.1	Examination of Product	Meets requirements of product drawing	Acceptable
		Electrical Requirements	
	Low Level Contact	•30mΩ Max. (Initial and Final)	
2.5.2	Resistance (LLCR)	<ul> <li>ΔR 10m Ω Max.(Final)</li> <li>Subject mated contacts assembled in housing to 20 mV Max. open circuit at 100 mA. As shown in Fig.4</li> </ul>	Acceptable
2.5.3	Dielectric withstanding Voltage (DWV)	<ul> <li>There shall be no evidence of arc-over, insulation breakdown or leakage current in excess of 1mA</li> <li>500Vrms at 60Hz,for 1minute</li> <li>Mated connector</li> </ul>	Acceptable
2.5.4	Insulation Resistance (I.R)	<ul> <li>The insulation resistance of mated connectors shall not be less than 500MΩ</li> <li>100V DC, for 2minute</li> <li>Mated connector</li> </ul>	Acceptable
2.5.5	Temperature Rising	<ul> <li>·30°C Max.</li> <li>·1.5 Amps RMS continues</li> <li>·3.5 Amps RMS over any 2 second time period</li> </ul>	Acceptable
		Mechanical Requirements	
2.5.6	Mechanical Shock	<ul> <li>No electrical discontinuity greater than 25 µ sec. shall occur</li> <li>100g's,6ms duration, 1/2 sine pulse</li> <li>3 shocks in each direction</li> <li>3 mutually perpend, planes 18 shocks total</li> </ul>	Acceptable
2.5.7	Vibration	<ul> <li>No electrical discontinuity greater than 25 µ sec. shall occur</li> <li>Random Vibration</li> <li>3 mutually perpend. Planes, 15g peak</li> <li>10-2000Hz, 0.4g2/Hz, 20min per plane</li> </ul>	Acceptable
2.5.8	Insertion Force (Mating Force)	<ul> <li>1Pos.: 1 N Max.</li> <li>Operation Speed: 100mm/min.</li> </ul>	Acceptable

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Para.	Test Items	Requirements	Procedures
	Withdrawal Force	•1Pos.: 0.1 N Min.	
2.5.9	(Un-mating Force)	Operation Speed: 100mm/min.	Acceptable
	Durability	No contact crack allowed	
2.5.10	(Automatic Operation)	Operation Speed: 600cycles/hour Max.	Acceptable
2.0.10		Number of Cycles: 1000 cycles	Acceptable
		•As shown in Fig.5-1, 5-2.	
	Manual Durability	No contact crack allowed	
2.5.11		Number of Cycles: 1000 cycles	Acceptable
		•As shown in Fig.5-1, 5-2	
		Environmental Requirements	
	Thermal Shock	No physical damage allowed	
		Mated connector,	
2.5.12		•-55°C/30min. 105°C/30min.	Acceptable
		•5 cycles.	
	Cyclic Humidity	No physical damage allowed	
		Mated connector	
2.5.13		•25°C±3°C at 80%±3% RH and	Acceptable
		65℃±3℃ at 50%±3% RH.	
		•24cycles (dwell time:1h)	
		•Ramp time: 0.5h	
	Temperature Life	No physical damage allowed	
2.5.14	(Heat Aging)	Mated connector	Acceptable
		•85°C for 120 hours	
	Salt Spray	<ul> <li>No corrosion that damages function of connector allowed</li> </ul>	
2.5.15		Mated connectors with	Acceptable
		5%, 35°C concentration for 96hours	
	Resistance to Reflow	No physical damage allowed	
2.5.16	Heat	Temperature profile: J-STD-020D	Acceptable

Fig. 2 (End)

#### 3. Product Qualification's Test Flow

			Т	est Gro	oup		
Test Examination	1	2	3	4	5	6	7
			Те	st Flow	(a)		
Examination of Product	1,9	1,14	1,10	1,8	1,6	1,10	1,4
Resistance to Reflow heat	2	2	2		2	2	2
Low Level Contact resistance(LLCR)	3,6	5,9, 11,13	5,7		3,5	5,7	
Dielectric Withstanding Voltage(DWV)				2,6			
Insulation Resistance(I.R)				3,7			
Temperature Rising							3
Mechanical Shock	4						
Vibration	5						
Insertion(Mating) Force	7	3,7	3,8			3,8	
Withdrawal (Un-mating) Force	8	4,8	4,9			4,9	
Durability (Automatic Operation)		6					
Manual Durability			6				
Thermal Shock		10		4			
Cyclic Humidity		12		5			
Temperature Life (Heat Aging)						6	
Salt Spray					4		

Appendix 1 (a) Numbers indicate sequence in which the tests are performed.



#### 4. Test Results

Test	Test Items	N	Unit		Test Res	ults		Spec.	Judge-
Group	rest tierns		Unit	Max.	Min.	Ave.	S	Spec.	ment
	Examination of Product (Initial and End)	5	SET	The phy	vsical dan	nage didn	't occur.	No physical damage allowed	Accep- table
	Resistance to Reflowheat	5	SET	The phy	vsical dan	nage didn	't occur.	No physical damage allowed	Accep- table
	Mechanical Shock	5	SET	No disc	continuity than 2		greater	Maximum of 25µseconds	Accep- table
Group	Vibration	5	SET	No disc	continuity than 2		greater	Maximum of 25µseconds	Accep- table
1	LLCR (Initial)	20	mΩ	20.39	19.41	19.99	0.40	Initial: 30mΩ Max.	Accep- table
	LLCR (After Mechanical Shock & Vibration)	20	mΩ	21.01	19.79	20.53	0.48	After test: 30mΩMax. ΔR:10mΩ Max	Accep- table
	Insertion Force(End)	5	N	0.32	0.32 0.30 0.31 0.009			1Pos: 1N Max.	Accep- table
	Withdrawal Force(End)	5	N	0.15	0.14	0.146	0.005	1Pos:0.1N Min.	Accep- table

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### **Qualification Test Report**

Test	Test Items	N	Unit	Te	st Result	S		Spec.	Judge- ment
Group				Max.	Min.	Ave.	S		
	Examination of Product (Initial and End)	5	SET	The phys	sical dam	age didn't d	occur.	No physical damage allowed	Accep- table
	Resistance to Reflowheat	5	SET	The phys	sical dam	age didn't d	occur.	No physical damage allowed	Accep- table
	Durability (Automatic operation)	5	SET	Cont	act crack	didn't occu	ır.	No contact crack allowed.	Accep- table
	Thermal shock	5	SET	The phys	sical dam	age didn't d	occur.	No physical damage allowed	Accep- table
	Cyclic Humidity	5	SET	The phys	sical dam	age didn't d	occur.	No physical damage allowed	Accep- table
Group 2	Insertion Force (Initial)	5	N	0.34	0.32	0.33	0.008		Accep- table
	Insertion Force (End)	5	N	0.31	0.29	0.30	0.008	1Pos: 1N Max.	Accep- table
	Withdrawal Force(Initial)	5	Ν	0.18	0.15	0.16	0.013		Accep- table
	Withdrawal Force(End)	5	N	0.15	0.14	0.14	0.005	1Pos: 0.1N Min.	Accep- table
	LLCR (Initial)	20	mΩ	19.76	18.96	19.36	0.29	Initial: 30mΩ Max.	Accep- table
	LLCR (After durability)	20	mΩ	20.12	19.82	19.96	0.11	After test: 30mΩMax. ΔR:10mΩ Max	Accep- table
	LLCR(After thermal shock)	20	mΩ	21.81	20.91	21.32	0.34	After test: 30mΩMax. ΔR:10mΩ Max	Accep- table
	LLCR(After cyclic humidity)	20	mΩ	22.95	21.45 1. 3 (CON	22.25	0.53	After test: 30mΩMax. ΔR:10mΩ Max	Accep- table

Fig. 3 (CONT.)

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## **Qualification Test Report**

Test Group	Test Items	N	Unit		Test Re		S	Spec.	Judge- ment
	Examination of Product (Initial and End)	5	SET	Max. The p	ohysical	Ave. damage cur.	1	No physical damage allowed	Accep- table
	Resistance to Reflowheat	5	SET	The p		damage cur.	didn't	No physical damage allowed	Accep- table
	Manual durability	5	SET	Cont	tact crac	k didn't c	occur.	No contact crack allowed.	Accep- table
	Insertion Force (Initial)	5	N	0.34	0.3	0.32	0.015		Accep- table
Group 3	Insertion Force (End)	5	N	0.31	0.28	0.29	0.011	1Pos: 1N Max.	Accep- table
	Withdrawal Force (Initial)	5	N	0.17	0.14	0.16	0.011		Accep- table
	Withdrawal Force (End)	5	N	0.15	0.13	0.14	0.008	1Pos: 0.1N Min.	Accep- table
	LLCR (Initial)	20	mΩ	19.54	18.37	18.97	0.50	Initial: 30mΩ Max.	Accep- table
	LLCR (End)	20	mΩ	20.81	19.95	20.39	0.42	After test: 30mΩMax. ΔR:10mΩ Max	Accep- table

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## **Qualification Test Report**

Test Group	Test Items	N	Unit		Test Res	sults		Spec.	Judge- ment
Group				Max.	Min.	Ave.	S		ment
	Examination of Product (Initial and End)	5	SET	The	physical occ	-	didn't	No physical damage allowed	Accep- table
	Thermal Shock	5	SET	The	physical o	-	didn't	No physical damage allowed	Accep- table
	Cyclic humidity	5	SET	The	physical o	-	didn't	No physical damage allowed	Accep- table
Group	DWV (Initial)	5	SET	Curr	ent leaka	ge: 1mA	Max.	Current leakage: 1mA Max.	Accep- table
4	DWV (End)	5	SET	Curr	ent leaka	ge: 1mA	Max.	Current leakage: 1mA Max.	Accep- table
	I.R.(Initial)	5	GΩ	9.33	8.74	8.99	-	500MΩ Min.	Accep- table
	I.R.(End)	5	GΩ	9.12	8.35	8.80	-	500MΩ Min.	Accep- table

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### **Qualification Test Report**

Test Group	Test Items	N	Unit	Т	est Resu	lts		Spec.	Judge- ment
	Examination of Product (Initial and End)	5	SET	Max. The ph	Min. hysical da occu	-	S dn't	No physical damage allowed	Accep- table
	Resistance to Reflowheat	5	SET	The ph	iysical da occu	-	dn't	No physical damage allowed	Accep- table
Group 5	Salt Spray	5	SET		osion tha n of conr occu	nector di		No corrosion that damages function of connector allowed.	Accep- table
	LLCR (Initial)	20	mΩ	20.01	18.92	19.51	0.43	Initial: 30mΩ Max.	Accep- table
	LLCR (End)	20	mΩ	22.41	20.17	21.44	0.96	After test: 30mΩMax. ΔR:10mΩ Max	Accep- table

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Test Group	Test Items	N	Unit	Max.	Test Res Min.	ults Ave.	S	Spec.	Judge- ment
	Examination of Product (Initial and End)	5	SET			nage didn'		No physical damage allowed	Accep- table
	Resistance to Reflowheat	5	SET	The ph	ysical dar	nage didn'	't occur.	No physical damage allowed	Accep- table
	Temperature Life	5	SET	The ph	ysical dar	nage didn'	't occur.	No physical damage allowed	Accep- table
Group	Insertion Force (Initial)	5	N	0.38	0.34	0.36	0.016		Accep- table
6	Insertion Force (End)	5	N	0.35	0.32	0.33	0.013	1 Pos: 1N Max.	Accep- table
	Withdrawal Force (Initial)	5	N	0.19	0.16	0.17	0.013		Accep- table
	Withdrawal Force (End)	5	N	0.16	0.14	0.15	0.009	1 Pos: 0.1N Min.	Accep- table
	LLCR (Initial)	20	mΩ	20.02	18.94	19.51	0.44	Initial: 30mΩ Max.	Accep- table
	LLCR (End)	20	mΩ	21.08	20.69	20.93	0.16	After test: 30mΩMax. ΔR:10mΩ Max	Accep- table

Test Group	Test It	ems	N	Unit	Max.	Test Res Min.	ults Ave.	S	Spec.	Judge- ment
	Examination of Product 5 SET (Initial and End)					physical occ	damage d		No physical damage allowed	Accep- table
Group 7	Resistance to Reflowheat	)	5	SET	The	physical o	-	lidn't	No physical damage allowed	Accep- table
	7 1.5A Tempe- Continue		5	°C	21.6	21.6 -			20 <sup>0</sup> 2 M	Accep- table
	rature Life	3.5A 2seconds	5	°C	24.8 -				30°C Max.	Accep- table

Fig. 3 (End)



Fig.4 Termination Resistance Measuring Points



Fig.3-1 Displacement allowance for durability test



Fig.3-2 Tilt allowance for durability test

The displacement and tilt of the connectors should meet Fig.3-1 and 3-2 . Any contacts should not hit PCB of mating side.